Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/602,374	CHIN ET AL.	
Examiner	Art Unit	
Fazli Erdem	2826	

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Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated 800	°b/rlls	J-PE